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ISSUE 267

SIGNAL PROCESSING

**DIY, MCU-Based
Camera Controller**

**Avoid Concurrency
Problems When Designing**

**MOSFETs at Different
Temperatures**

**A MEMS Solution
for Gyro Stability**

**FAT Cache Technique to
Optimize SD Card Access**

PLUS

Embedded Inquiries

- // STT-RAM-Based Memory Hierarchy
- // The Future of System Design
- // Next-Generation NVM Technology
- // And More



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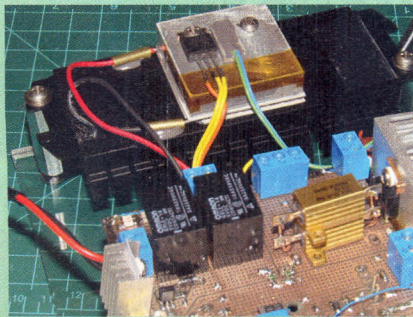
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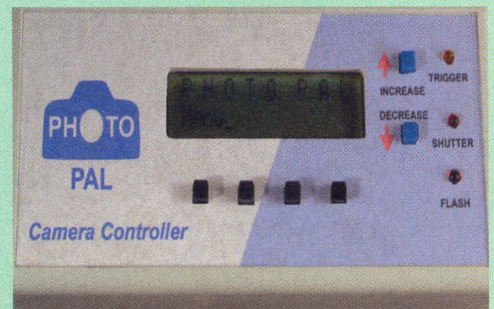
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Go Team!

Steve Ciarcia